# **Analysis of the Bunch Position Monitoring** in Long Bunch Trains at FLASH.

**Nicoleta Baboi, Bastian Lorbeer (DESY, Hamburg)** 



### Abstract

### The FLASH Free Electron Laser, DESY, Hamburg

### **Typical parameters**

Multi-bunch beams are routinely being accelerated at the FLASH Free Electron Laser at DESY, Hamburg. More than hundred Beam Position Monitors (BPMs) measure the transverse offset of every single bunch in each train with a bunch repetition frequency of up to 1 MHz and a length of several hundreds of microseconds. Various types of monitors are being used: button, stripline and cavity BPMs, each type with several designs. The performance differs from type to type, with resolutions from one to tens of micrometers. However so far only the first bunch in the train was investigated in detail. In this paper we study

#### User and test facility

The Free electron LASer in Hamburg (FLASH) produces ultra short intense XUV and soft X-ray pulses. A photoelectric gun produces electron bunch trains with a repetition frequency of up to 1 MHz.. The TESLA superconducting accelerating technology enables the acceleration of trains of hundreds of bunches with a frequency of 10 Hz. Two bunch compressors are used to reduce the bunch length to tens to hundreds of fs. The train is split then to the two undulator beamlines, enabling multi-user operation in the two experimental halls [1].

#### **Diagnostics**

Many of diagnostics monitors installed in FLASH are able to measure each single bunch in the bunch train: toroid, measuring the bunch charge, beam position monitors (BPMs), beam loss monitors. OTR and scintillator-based screen stations and wire scanners offer the transverse beam profile. Longitudinal diagnostics, such as the bunch compression monitors, beam arrival monitors, transverse deflecting structure allow the precise control of the bunch length and time synchronization, essential for many experiments.

Parameter	FLASH1	FLASH2
Electron beam energy	0.35 - 1.25 GeV	0.4 - 1.25 GeV
Normalised emittance at 1 nC (rms)	1.4 mm mrad	1.4 mm mrad
Energy spread	200 keV	500 keV
Electron bunch charge	0.1 - 1.2 nC	0.02 - 1 nC
Peak current	1 - 2.5 kA	1 - 2.5 kA



Single bunch resolution for a bunch charge of ca. 0.4 nC (first bunch)

### **BPMs in FLASH**

# **BPM Resolution**

## **Resolution vs. Offset**











Horizontal beam position scan for stripline BPMs

**Resolution vs. beam position.** 

3DBC2-X
7DBC2-X
9DBC2-X
3DBC2-Y
3DBC2-Y
7DBC2-Y





range of ca.  $\pm$  5mm.

Summary

No dependence of the single bunch resolution has been observed along the bunch train.

X [mm

No change in the resolution within the measurement

Also, not significant change was observed for various bunch frequencies.

The resolution stays unchanged within the transverse measurements range of the stripline-BPMs: ca.  $\pm$  5mm.



[1] J. Roensch-Schulenburg et al., "FLASH - Status and Upgrades", FEL'19, Hamburg, Germany, FRA03.

[2] B. Lorbeer et al., "High Resolution and Low Charge Button and Strip-Line Beam Position Monitor Electronics Upgrade at FLASH",





#### IPAC'18, Vancouver, Canada, p. 1923 (2018).

[3] N. Baboi et al., "Resolution Studies at Beam Position Monitors at the FLASH Facility at DESY", in *AIP Conference Proceedings* 868, 227 (2006).

#### Mean, std and resolution of BPM reading for each bunch in the train 200 bunch trains

There is a variation of the beam position along the train and also of the charge (right, upper plot)

The standard deviation increases for the stripline BPM towards the end of the train.

The difference in the resolution for different repetition frequencies is due to the different bunch charge.

### Mean, std and resolution of charge reading

The charge changed when changing the bunch repertition frequency, which explains the slight change in the BPM resolution.





